

# ISO/TS 19590:2024-08 (E)

## Nanotechnologies - Characterization of nano-objects using single particle inductively coupled plasma mass spectrometry

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<b>Contents</b>		<b>Page</b>
Foreword .....		iv
Introduction .....		v
1	Scope .....	1
2	Normative references .....	1
3	Terms and definitions .....	1
4	Abbreviated terms .....	3
5	Principles of operation .....	4
5.1	Introduction to spICP-MS .....	4
5.2	Reference material dependent calibration methods .....	6
5.2.1	Particle frequency method .....	6
5.2.2	Particle size method .....	8
5.3	Reference material free calibration methods .....	9
5.3.1	Dynamic mass flow method .....	9
5.3.2	Microdroplet calibration method .....	11
5.4	Particle number concentration determination .....	13
5.5	Particle mass and corresponding spherical equivalent diameter determination .....	14
5.6	Dissolved element fraction .....	17
5.7	Multi-isotope and multi-elemental analysis .....	17
5.8	Data treatment .....	18
6	Method development .....	19
6.1	Sample specification .....	19
6.2	Sample preparation .....	19
6.2.1	Aqueous suspensions and paste .....	20
6.2.2	Non-aqueous suspensions and creams .....	20
6.2.3	Powders .....	21
6.2.4	Larger pieces of solids .....	21
6.3	Selection of reference materials, quality control materials and representative test materials .....	21
6.4	Optimization of ICP-MS operating conditions .....	22
7	Qualification, performance criteria and measurement uncertainty .....	23
7.1	Applicability of spICP-MS .....	23
7.2	System qualification and quality control .....	23
7.3	Method performance criteria .....	24
7.3.1	Particle number concentration .....	24
7.3.2	Particle mass and equivalent spherical diameter .....	24
7.4	Method precision and measurement uncertainty .....	25
8	General measurement procedure .....	25
9	Test report .....	26
9.1	Apparatus and measurement parameters .....	26
9.2	Reporting test results .....	26
Bibliography .....		27